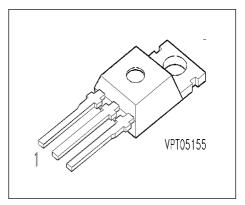
### **SIPMOS** ® Power Transistor

- P channel
- Enhancement mode
- Avalanche rated



Pin 1	Pin 2	Pin 3
G	D	S

Туре	V <sub>DS</sub>	I <sub>D</sub>	R <sub>DS(on)</sub>	Package	Ordering Code
BUZ 172	-100 V	-5.5 A	0.6 Ω	TO-220 AB	C67078-S1451-A2

### **Maximum Ratings**

Parameter	Symbol	Values	Unit
Continuous drain current	I <sub>D</sub>		Α
$T_{\rm C}$ = 37 °C		-5.5	
Pulsed drain current	/ <sub>Dpuls</sub>		
$T_{\rm C}$ = 25 °C		-22	
Avalanche energy, single pulse	E <sub>AS</sub>		mJ
$I_{\rm D} = -5.5 \; {\rm A}, \; V_{\rm DD} = -25 \; {\rm V}, \; R_{\rm GS} = 25 \; {\rm \Omega}$			
$L = 8.4 \text{ mH}, T_j = 25 \text{ °C}$		170	
Gate source voltage	$V_{GS}$	± 20	V
Power dissipation	P <sub>tot</sub>		W
$T_{\rm C}$ = 25 °C		40	
Operating temperature	$T_{\rm j}$	-55 <b>+</b> 150	°C
Storage temperature	$T_{ m stg}$	-55 <b>+</b> 150	
Thermal resistance, chip case	R <sub>thJC</sub>	≤ 3.1	K/W
Thermal resistance, chip to ambient	R <sub>thJA</sub>	≤ 75	
DIN humidity category, DIN 40 040		Е	
IEC climatic category, DIN IEC 68-1		55 / 150 / 56	



## **Electrical Characteristics,** at $T_j = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Static Characteristics					
Drain- source breakdown voltage	V <sub>(BR)DSS</sub>				V
$V_{\rm GS}$ = 0 V, $I_{\rm D}$ = -0.25 mA, $T_{\rm j}$ = 25 °C		-100	-	-	
Gate threshold voltage	V <sub>GS(th)</sub>				
$V_{\text{GS}} = V_{\text{DS}}$ , $I_{\text{D}} = 1 \text{ mA}$		-2.1	-3	-4	
Zero gate voltage drain current	I <sub>DSS</sub>				μA
$V_{\rm DS}$ = -100 V, $V_{\rm GS}$ = 0 V, $T_{\rm j}$ = 25 °C		-	-0.1	-1	
$V_{\rm DS}$ = -100 V, $V_{\rm GS}$ = 0 V, $T_{\rm j}$ = 125 °C		-	-10	-100	
Gate-source leakage current	I <sub>GSS</sub>				nA
$V_{\text{GS}}$ = -20 V, $V_{\text{DS}}$ = 0 V		-	-10	-100	
Drain-Source on-resistance	R <sub>DS(on)</sub>				Ω
$V_{GS} = -10 \text{ V}, I_D = -3.7 \text{ A}$		-	0.4	0.6	



## **Electrical Characteristics**, at $T_j = 25$ °C, unless otherwise specified

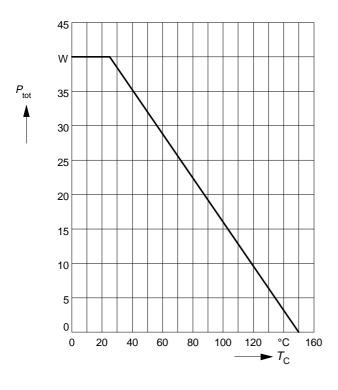
Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Dynamic Characteristics					
Transconductance	<i>g</i> fs				S
$V_{\rm DS} \ge 2 * I_{\rm D} * R_{\rm DS(on)max}, I_{\rm D} = -3.7 \text{ A}$		1	2	-	
Input capacitance	$C_{iss}$				pF
$V_{GS} = 0 \text{ V}, \ V_{DS} = -25 \text{ V}, \ f = 1 \text{ MHz}$		-	800	1200	
Output capacitance	Coss				
$V_{GS} = 0 \text{ V}, V_{DS} = -25 \text{ V}, f = 1 \text{ MHz}$		-	220	330	
Reverse transfer capacitance	$C_{rss}$				
$V_{GS} = 0 \text{ V}, \ V_{DS} = -25 \text{ V}, \ f = 1 \text{ MHz}$		-	90	140	
Turn-on delay time	$t_{d(on)}$				ns
$V_{\rm DD}$ = -30 V, $V_{\rm GS}$ = -10 V, $I_{\rm D}$ = -2.8 A					
$R_{\rm GS} = 50 \ \Omega$		-	20	30	
Rise time	$t_{r}$				
$V_{\rm DD}$ = -30 V, $V_{\rm GS}$ = -10 V, $I_{\rm D}$ = -2.8 A					
$R_{\rm GS} = 50 \ \Omega$		-	120	180	
Turn-off delay time	$t_{d(off)}$				
$V_{\rm DD}$ = -30 V, $V_{\rm GS}$ = -10 V, $I_{\rm D}$ = -2.8 A					
$R_{\rm GS} = 50 \ \Omega$		-	70	90	
Fall time	<i>t</i> <sub>f</sub>				
$V_{\rm DD}$ = -30 V, $V_{\rm GS}$ = -10 V, $I_{\rm D}$ = -2.8 A					
$R_{\rm GS}$ = 50 $\Omega$		-	55	75	

## **Electrical Characteristics**, at $T_j = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Reverse Diode					
Inverse diode continuous forward current	Is				Α
<i>T</i> <sub>C</sub> = 25 °C		-	-	-5.5	
Inverse diode direct current,pulsed	/ <sub>SM</sub>				
<i>T</i> <sub>C</sub> = 25 °C		-	-	-22	
Inverse diode forward voltage	V <sub>SD</sub>				V
$V_{GS} = 0 \text{ V}, I_{F} = -11 \text{ A}$		-	-1	-1.3	
Reverse recovery time	t <sub>rr</sub>				ns
$V_{\rm R}$ = -30 V, $I_{\rm F} = I_{\rm S}$ , $di_{\rm F}/dt$ = 100 A/ $\mu$ s		-	200	-	
Reverse recovery charge	Q <sub>rr</sub>				μC
$V_{R}$ = -30 V, $I_{F}=I_{S_{,}} dI_{F}/dt$ = 100 A/ $\mu$ s		-	0.75	-	

#### **Power dissipation**

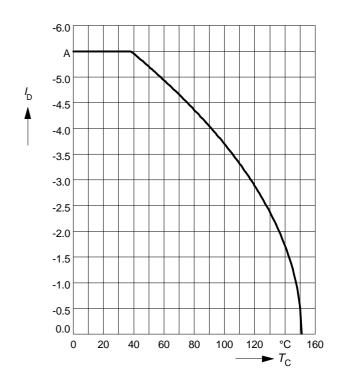
$$P_{\mathsf{tot}} = f(T_{\mathsf{C}})$$



#### **Drain current**

 $I_{\mathsf{D}} = f(T_{\mathsf{C}})$ 

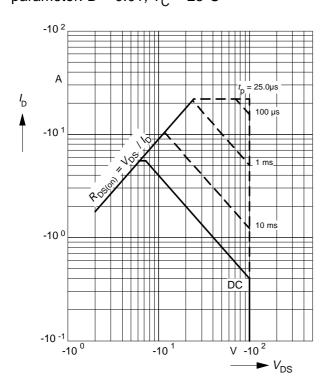
parameter:  $V_{GS} \ge -10 \text{ V}$ 



### Safe operating area

$$I_{\mathsf{D}} = f(V_{\mathsf{DS}})$$

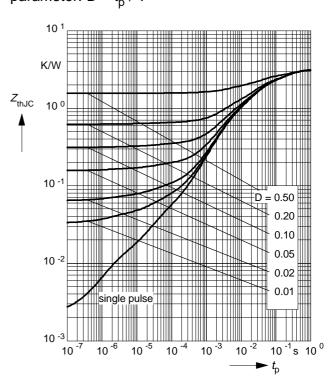
parameter: D = 0.01,  $T_C = 25$ °C



#### **Transient thermal impedance**

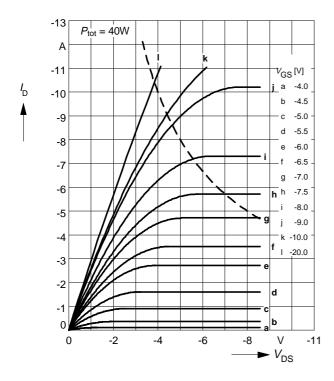
$$Z_{\mathsf{th\ JC}} = f(t_{\mathsf{p}})$$

parameter:  $D = t_p / T$ 



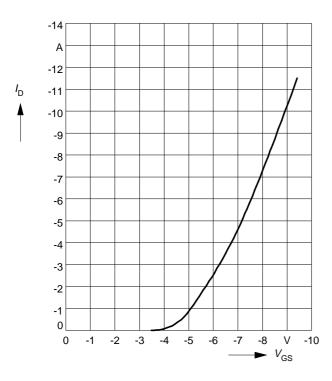
### Typ. output characteristics

 $I_{\rm D} = f(V_{\rm DS})$  parameter:  $t_{\rm p} = 80~\mu{\rm s}$ 



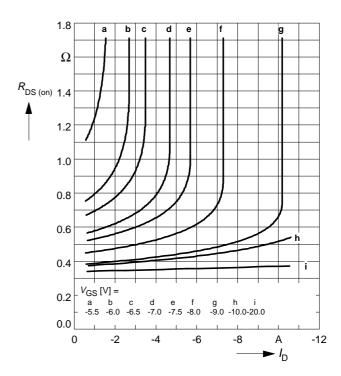
Typ. transfer characteristics  $I_D = f(V_{GS})$ 

parameter:  $t_p = 80 \mu s$  $V_{DS} \ge 2 \times I_D \times R_{DS(on)max}$ 



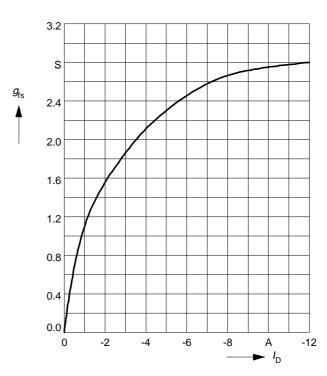
#### Typ. drain-source on-resistance

 $R_{\text{DS (on)}} = f(I_{\text{D}})$  parameter:  $V_{\text{GS}}$ 



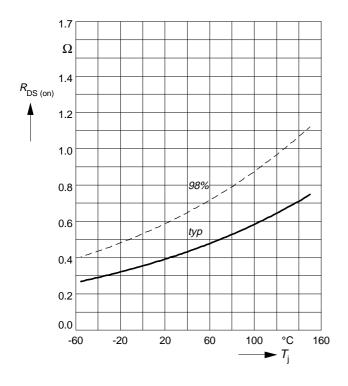
### Typ. forward transconductance $g_{fs} = f(I_D)$

parameter:  $t_p = 80 \mu s$ ,  $V_{DS} \ge 2 \times I_D \times R_{DS(on)max}$ 



#### **Drain-source on-resistance**

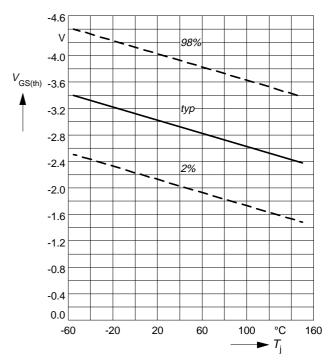
 $R_{\rm DS~(on)} = f(T_{\rm j})$  parameter:  $I_{\rm D}$  = -3.7 A,  $V_{\rm GS}$  = -10 V



#### Gate threshold voltage

 $V_{\text{GS (th)}} = f(T_{\text{j}})$ 

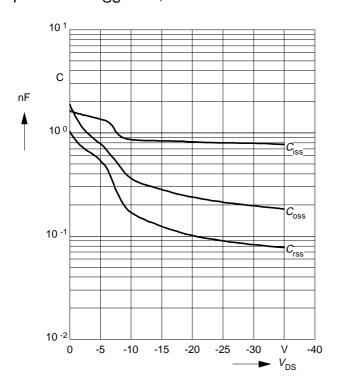
parameter:  $V_{GS} = V_{DS}$ ,  $I_{D} = 1 \text{ mA}$ 



### Typ. capacitances

 $C = f(V_{DS})$ 

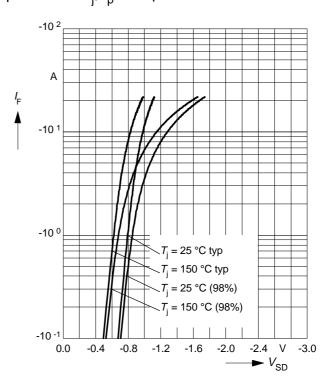
parameter:  $V_{GS} = 0V$ , f = 1MHz



#### Forward characteristics of reverse diode

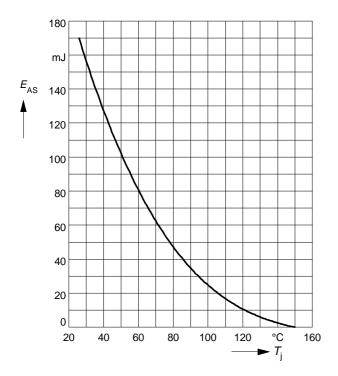
 $I_{\mathsf{F}} = f(V_{\mathsf{SD}})$ 

parameter:  $T_i$ ,  $t_p = 80 \mu s$ 



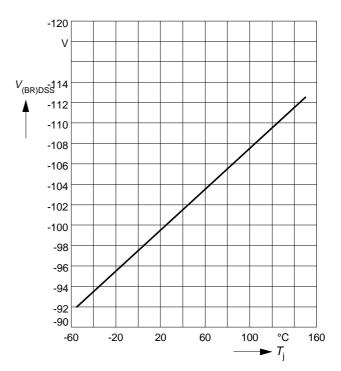
## Avalanche energy $E_{AS} = f(T_j)$

parameter:  $I_D = -5.5 \text{ A}$ ,  $V_{DD} = -25 \text{ V}$   $R_{GS} = 25 \Omega$ , L = 8.4 mH



#### Drain-source breakdown voltage

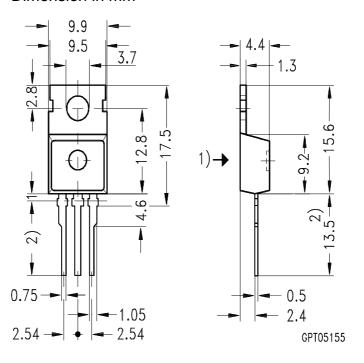
 $V_{(\mathsf{BR})\mathsf{DSS}} = f(T_{\mathsf{j}})$ 



### **Package Outlines**

TO-220 AB

Dimension in mm



- 1) punch direction, burr max. 0.04
- 2) dip tinning
- 3) max. 14.5 by dip tinning press burr max. 0.05